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# N-Channel 30 V (D-S) MOSFET

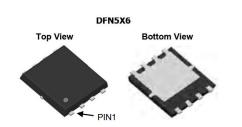
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ )(Typ.)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
30	6.3 at V <sub>GS</sub> = 10 V	62	22.5 - 0		
	13.5 at V <sub>GS</sub> = 4.5 V	38	22.5 nC		

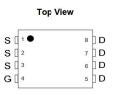
#### **FEATURES**

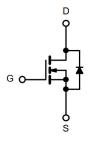
- · DT-Trench Power MOSFET
- 100 % R<sub>q</sub> and UIS Tested

### **APPLICATIONS**

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		62 <sup>a, e</sup>		
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C	1 .	50 <sup>e</sup>		
Continuous Diam Current (1,1 - 175 C)	T <sub>A</sub> = 25 °C	. I <sub>D</sub>	11 <sup>b, c</sup>	A	
	T <sub>A</sub> = 70 °C		8.3 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	186	1	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	56		
Single Pulse Avalanche Energy	L = 0.1 min	E <sub>AS</sub>	45	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	62 <sup>a, e</sup>	А	
Oorkindods Godree-Brain Blode Gurrent	T <sub>A</sub> = 25 °C	'5	2.32 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		168 <sup>a</sup>		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	118	w	
	T <sub>A</sub> = 25 °C	טי	3.26 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		2.28 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	35	46	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.5	0.89		

- Notes:
  a. Based on T<sub>C</sub> = 25 °C.
  b. Surface mounted on 1" x 1" FR4 board.
  c. t = 10 s.
  d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature.



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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static				<u> </u>			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	30			٧	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		35		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	Ι <sub>D</sub> – 230 μΑ		- 5.5		mv/ C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.8		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	i	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1		
	DSS	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	80			Α	
		$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		6.3	7.8	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		13.5	16.5		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A		125		S	
Dynamic <sup>b</sup>					1		
Input Capacitance	C <sub>iss</sub>			1010		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		130			
Reverse Transfer Capacitance	C <sub>rss</sub>			113			
Total Gate Charge	Qg			22.5		nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		2			
Gate-Drain Charge	Q <sub>gd</sub>			5.5			
Gate Resistance	R <sub>q</sub>	f = 1 MHz		3		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			30			
Rise Time	t <sub>r</sub>	$V_{DD} = 24 \text{ V}, R_{L} = 0.555 \Omega$		15		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 30$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		78			
Fall Time	t <sub>f</sub>			14			
Turn-On Delay Time	t <sub>d(on)</sub>			60			
Rise Time	t <sub>r</sub>	$V_{DD} = 24 \text{ V}, R_{L} = 0.625 \Omega$		165			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 20$ A, $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$		55			
Fall Time	t <sub>f</sub>			17			
<b>Drain-Source Body Diode Characteristic</b>	S						
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			62		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				186	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A		0.6	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			55	73	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 30 A di/dt = 100 A/vo T = 25 °C		68	102	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 30 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		30		-	
Reverse Recovery Rise Time	t <sub>b</sub>			22		ns	

#### Notes:

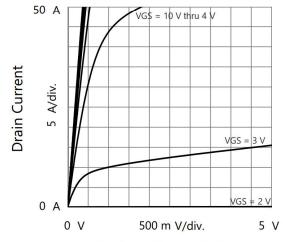
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

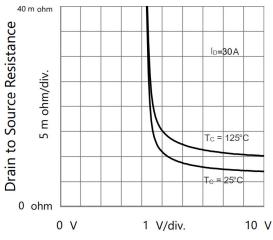




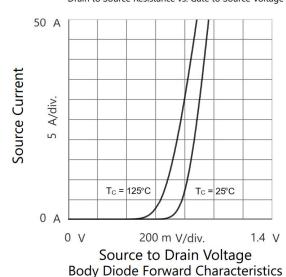
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

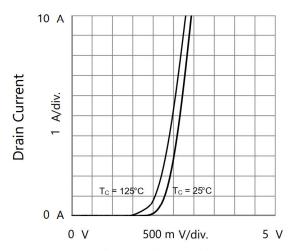


Drain to Source Voltage Output Characteristics

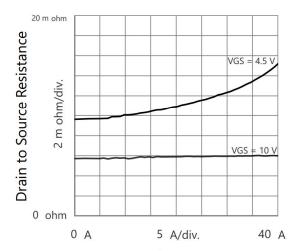


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

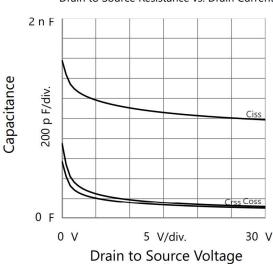




Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current

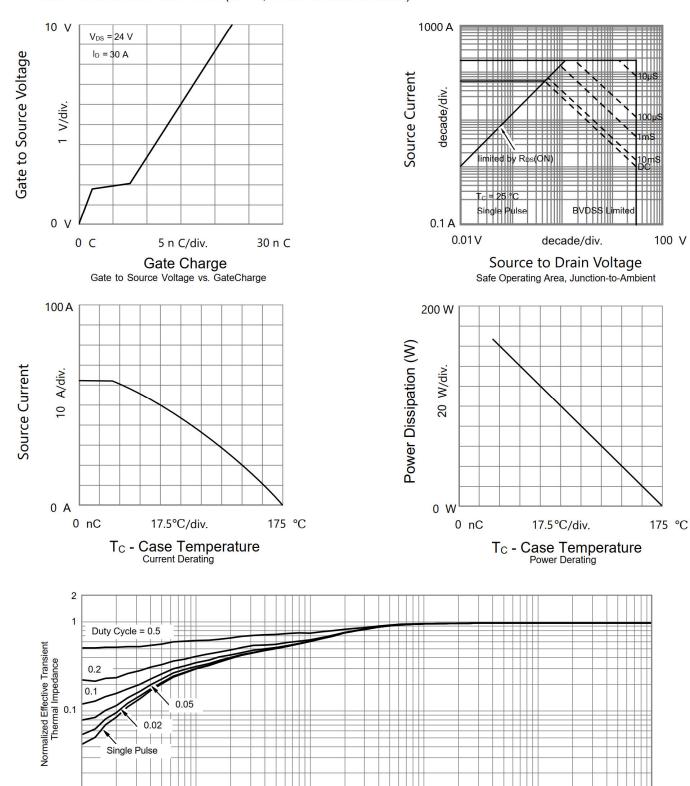




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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Square Wave Pulse Duration (s)

Normalized Thermal Transient Impedance, Junction-to-Case

10-1

1

10-2

10





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